

Notice of References Cited	Application/Control No. 09/985,870	Applicant(s)/Patent Under Reexamination SMALL ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-5,858,813 ✓	01-1999	Scherber et al.	438/693
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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